

PHM18NQ15T

TrenchMOS™ standard level FET

Rev. 01 — 30 January 2003

Preliminary data

1. Product profile

1.1 Description

N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOS™ technology.

Product availability:

PHM18NQ15T in SOT685-1 (QLPAK).

1.2 Features

- SOT96 (SO-8) footprint compatible
- Surface mount package
- Low thermal resistance
- Low profile.

1.3 Applications

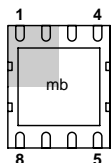
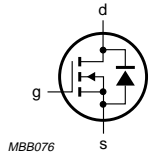
- DC-DC converter primary side switch
- Portable equipment applications.

1.4 Quick reference data

- $V_{DS} \leq 150 \text{ V}$
- $I_D \leq 17.9 \text{ A}$
- $P_{tot} \leq 62.5 \text{ W}$
- $R_{DSon} \leq 75 \text{ m}\Omega$.

2. Pinning information

Table 1: Pinning - SOT685-1 (QLPAK), simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1,2,3	source (s)	 <p>Bottom view MBL585</p>	 <p>MBB076</p>
4	gate (g)		
5,6,7,8	drain (d)		
mb	mounting base connected to drain (d)		

[1] Shaded area indicates pin 1 identifier.



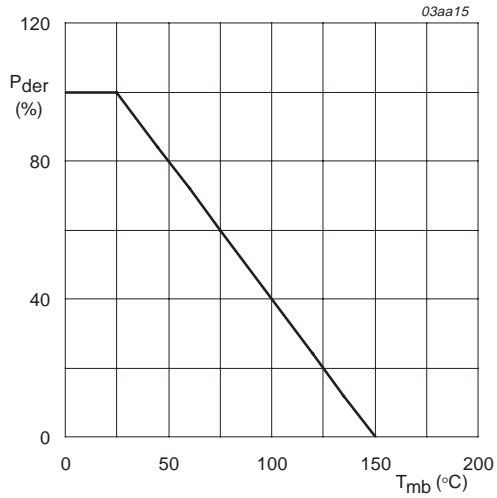
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3. Limiting values

Table 2: Limiting values

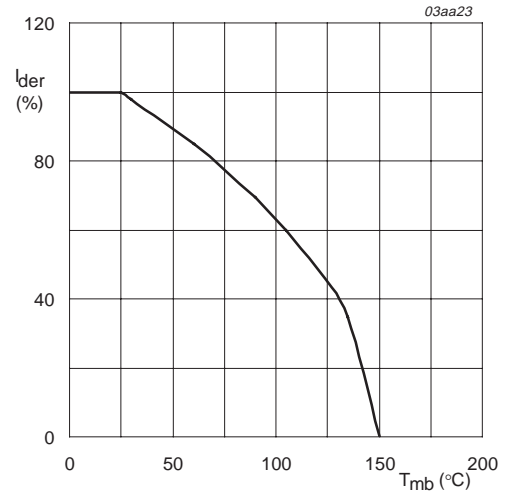
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$	-	150	V
V_{DGR}	drain-gate voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$; $R_{GS} = 20\text{ k}\Omega$	-	150	V
V_{GS}	gate-source voltage (DC)		-	± 20	V
I_D	drain current (DC)	$T_{mb} = 25\text{ °C}$; $V_{GS} = 10\text{ V}$; Figure 2 and 3	-	17.9	A
		$T_{mb} = 100\text{ °C}$; $V_{GS} = 10\text{ V}$; Figure 2	-	11.3	A
I_{DM}	peak drain current	$T_{mb} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$; Figure 3	-	60	A
P_{tot}	total power dissipation	$T_{mb} = 25\text{ °C}$; Figure 1	-	62.5	W
T_{stg}	storage temperature		-55	+150	°C
T_j	junction temperature		-55	+150	°C
Source-drain diode					
I_S	source (diode forward) current (DC)	$T_{mb} = 25\text{ °C}$	-	17.9	A
I_{SM}	peak source (diode forward) current	$T_{mb} = 25\text{ °C}$; pulsed; $t_p \leq 10\text{ }\mu\text{s}$	-	60	A



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

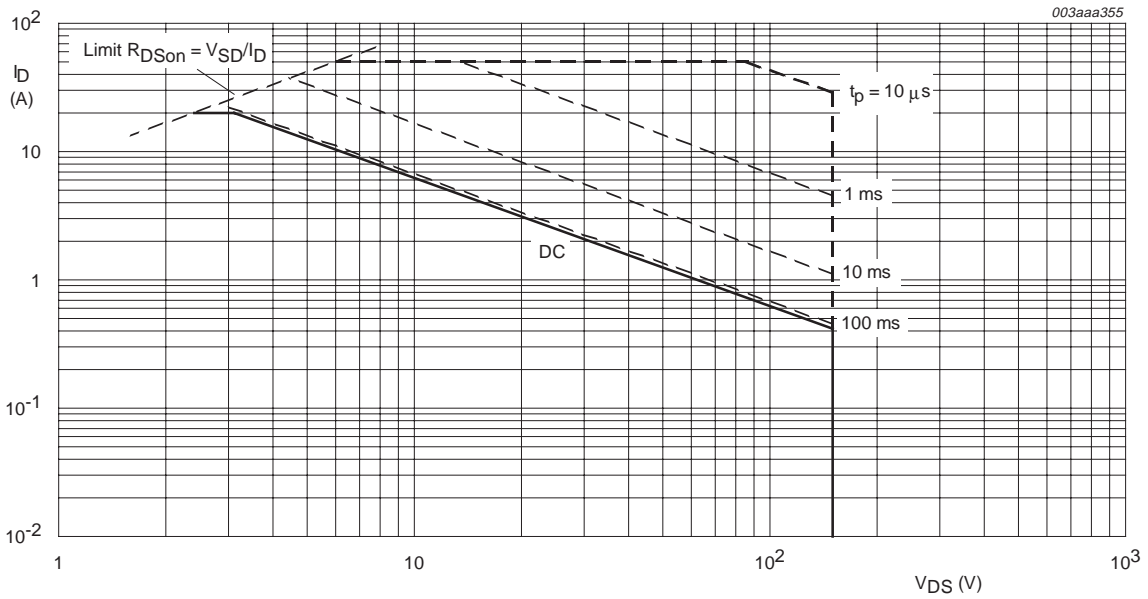
Fig 1. Normalized total power dissipation as a function of mounting base temperature.



$V_{GS} \geq 10\text{ V}$

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature.



$T_{mb} = 25^{\circ}C$; I_{DM} is single pulse.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

4. Thermal characteristics

Table 3: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Figure 4	-	-	2	K/W

4.1 Transient thermal impedance

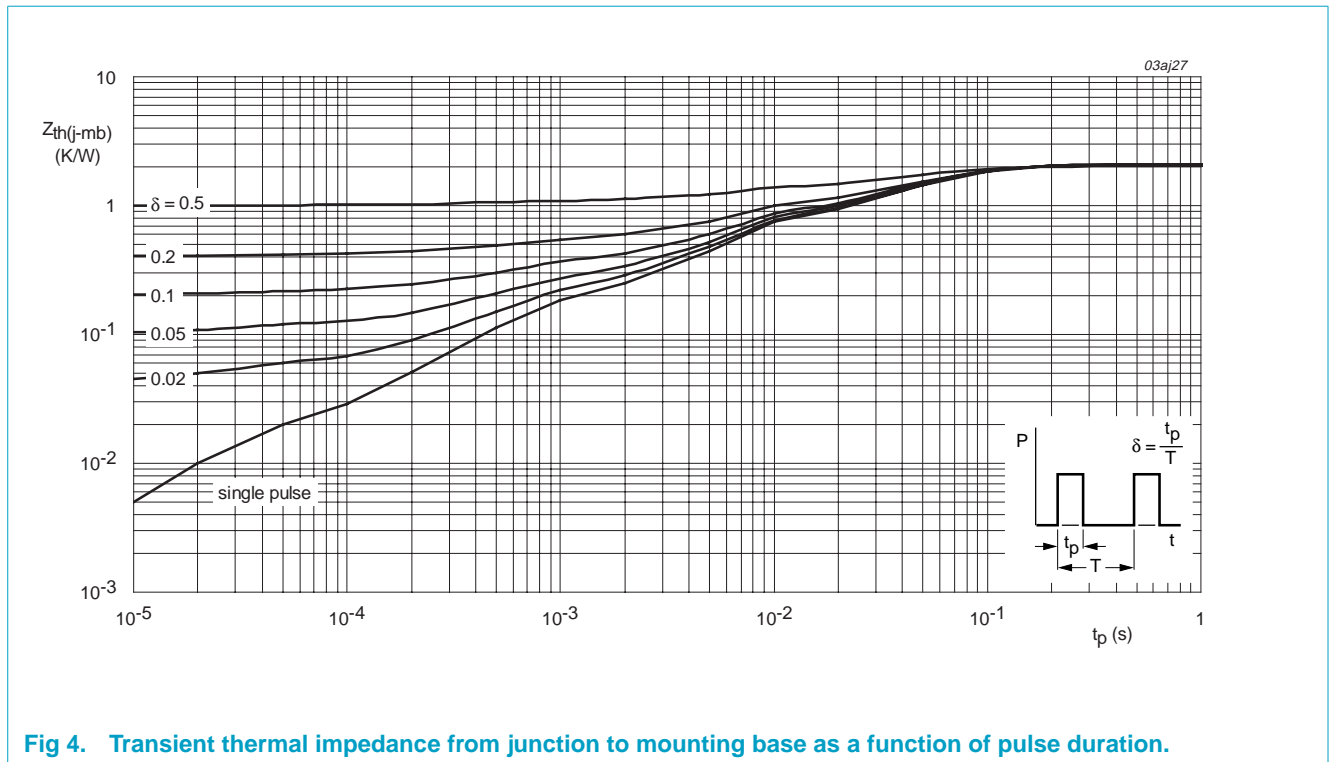
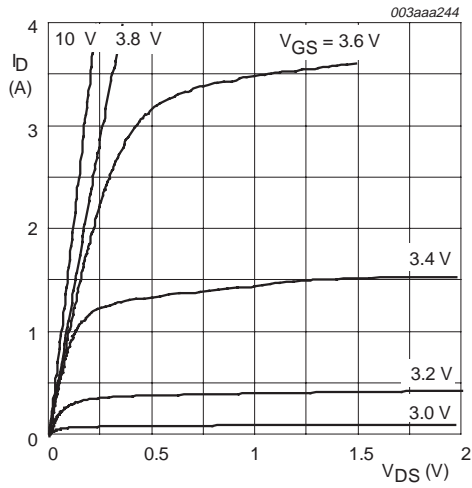


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

5. Characteristics

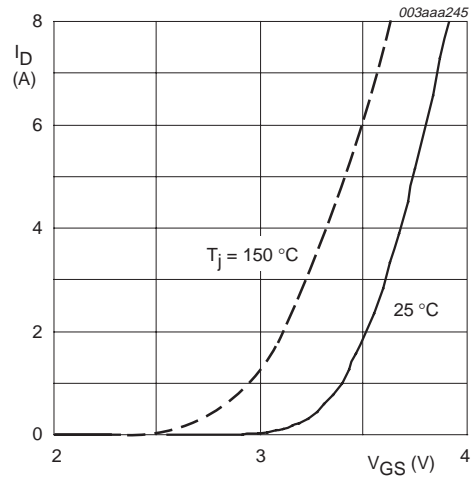
Table 4: Characteristics
 $T_j = 25\text{ °C}$ unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250\ \mu\text{A}$; $V_{GS} = 0\ \text{V}$ $T_j = 25\text{ °C}$	150	-	-	V
		$T_j = -55\text{ °C}$	134	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1\ \text{mA}$; $V_{DS} = V_{GS}$; Figure 9 $T_j = 25\text{ °C}$	2	3	4	V
		$T_j = 150\text{ °C}$	1.2	-	-	V
		$T_j = -55\text{ °C}$	-	-	6	V
I_{DSS}	drain-source leakage current	$V_{DS} = 120\ \text{V}$; $V_{GS} = 0\ \text{V}$ $T_j = 25\text{ °C}$	-	-	1	μA
		$T_j = 150\text{ °C}$	-	-	100	μA
I_{GSS}	gate-source leakage current	$V_{GS} = \pm 10\ \text{V}$; $V_{DS} = 0\ \text{V}$	-	10	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10\ \text{V}$; $I_D = 12\ \text{A}$; Figure 7 and 8 $T_j = 25\text{ °C}$	-	56	75	$\text{m}\Omega$
		$T_j = 150\text{ °C}$	-	129	173	$\text{m}\Omega$
		$V_{GS} = 5\ \text{V}$; $I_D = 3\ \text{A}$	-	60	80	$\text{m}\Omega$
Dynamic characteristics						
$Q_{g(tot)}$	total gate charge	$I_D = 5\ \text{A}$; $V_{DD} = 75\ \text{V}$; $V_{GS} = 10\ \text{V}$; Figure 13	-	29	-	nC
Q_{gs}	gate-source charge		-	3	-	nC
Q_{gd}	gate-drain (Miller) charge		-	12	-	nC
C_{iss}	input capacitance	$V_{GS} = 0\ \text{V}$; $V_{DS} = 25\ \text{V}$; $f = 1\ \text{MHz}$; Figure 12	-	1150	-	pF
C_{oss}	output capacitance		-	187	-	pF
C_{rss}	reverse transfer capacitance		-	61	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DD} = 75\ \text{V}$; $I_D = 5\ \text{A}$; $V_{GS} = 10\ \text{V}$; $R_G = 6\ \Omega$	-	12	-	ns
t_r	rise time		-	11	-	ns
$t_{d(off)}$	turn-off delay time		-	35	-	ns
t_f	fall time		-	18	-	ns
Source-drain diode						
V_{SD}	source-drain (diode forward) voltage	$I_S = 5\ \text{A}$; $V_{GS} = 0\ \text{V}$; Figure 11	-	0.76	1.2	V
t_{rr}	reverse recovery time	$I_S = 5\ \text{A}$; $di_S/dt = -100\ \text{A}/\mu\text{s}$; $V_R = 90\ \text{V}$;	-	87	-	ns
Q_r	recovered charge	$V_{GS} = 0\ \text{V}$	-	162	-	nC



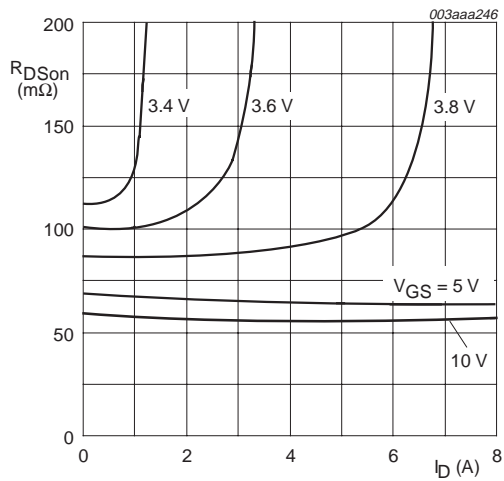
$T_j = 25\text{ }^\circ\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



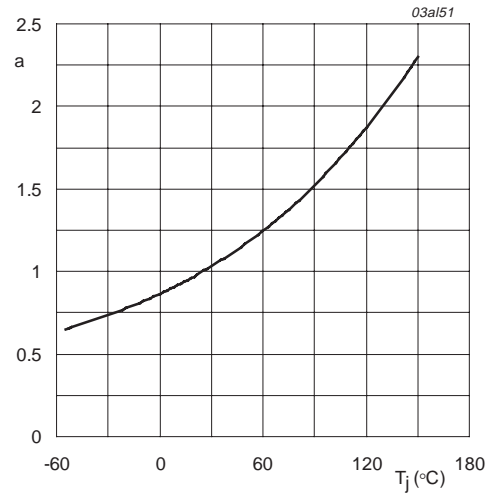
$T_j = 25\text{ }^\circ\text{C}$ and $150\text{ }^\circ\text{C}$; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



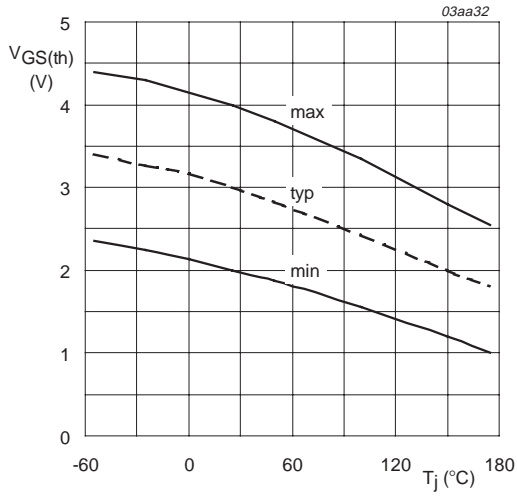
$T_j = 25\text{ }^\circ\text{C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



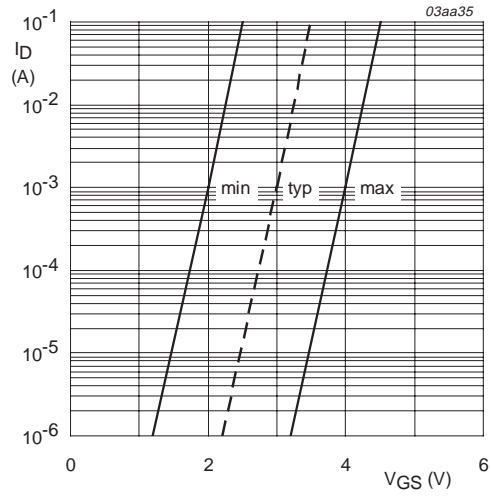
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



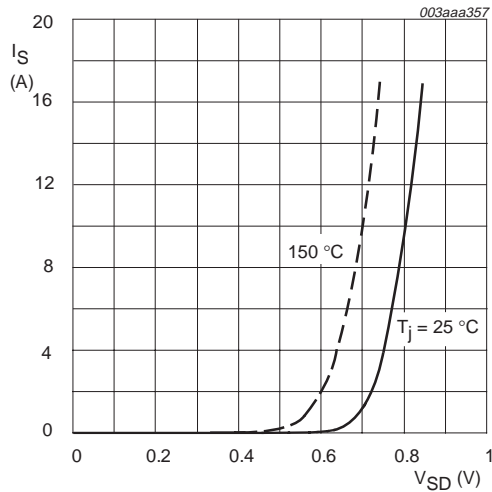
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



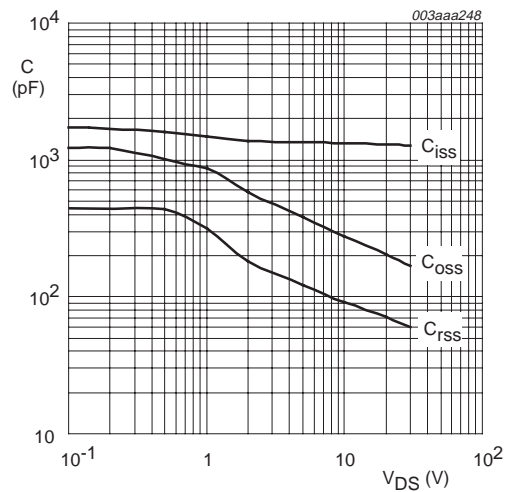
$T_j = 25 \text{ }^{\circ}C; V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



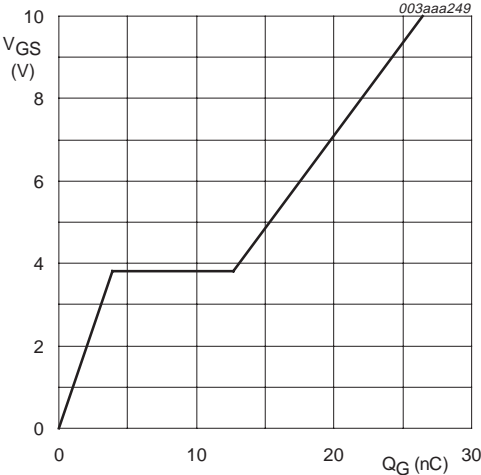
$T_j = 25 \text{ }^{\circ}C \text{ and } 150 \text{ }^{\circ}C; V_{GS} = 0 \text{ V}$

Fig 11. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



$I_D = 5\text{ A}; V_{DD} = 75\text{ V}$

Fig 13. Gate-source voltage as a function of gate charge; typical values.

6. Package outline

HVSON8: plastic thermal enhanced very thin small outline package; no leads; 8 terminals; body 6 x 5 x 0.85 mm

SOT685-1

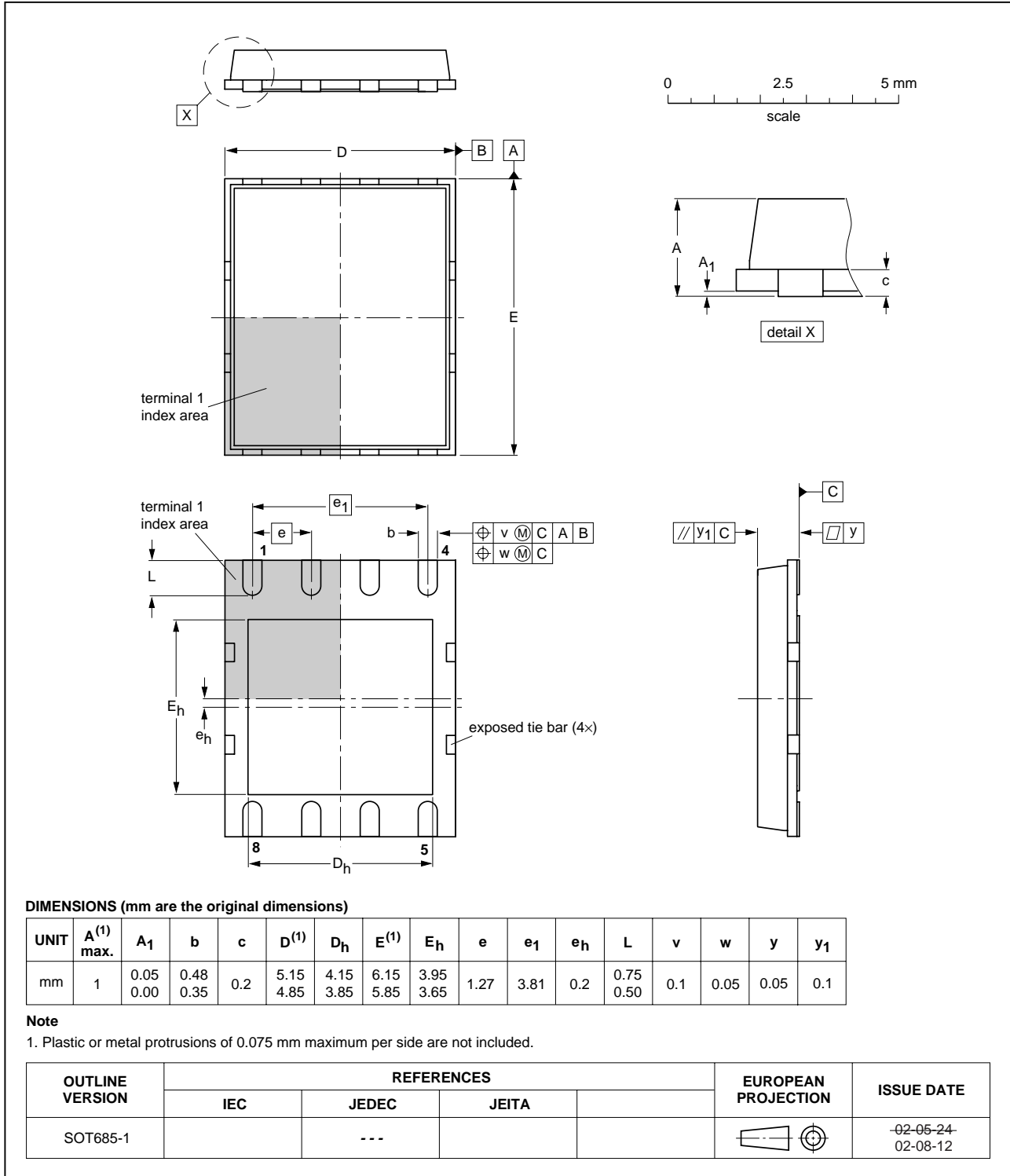


Fig 14. SOT685-1 (QLPAK).

7. Revision history

Table 5: Revision history

Rev	Date	CPCN	Description
01	20030130	-	Preliminary data (9397 750 10877)

8. Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2][3]}	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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Date of release: 30 January 2003

Document order number: 9397 750 10877



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